

Test Laboratory: Compliance Certification Services

HAC_H_Device Cell band_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA Cellular band; Frequency: 824.7 MHz; Duty Cycle: 1:1
 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
 Phantom section: H Device Section
 Measurement Standard: DASYS4 (High Precision Assessment)

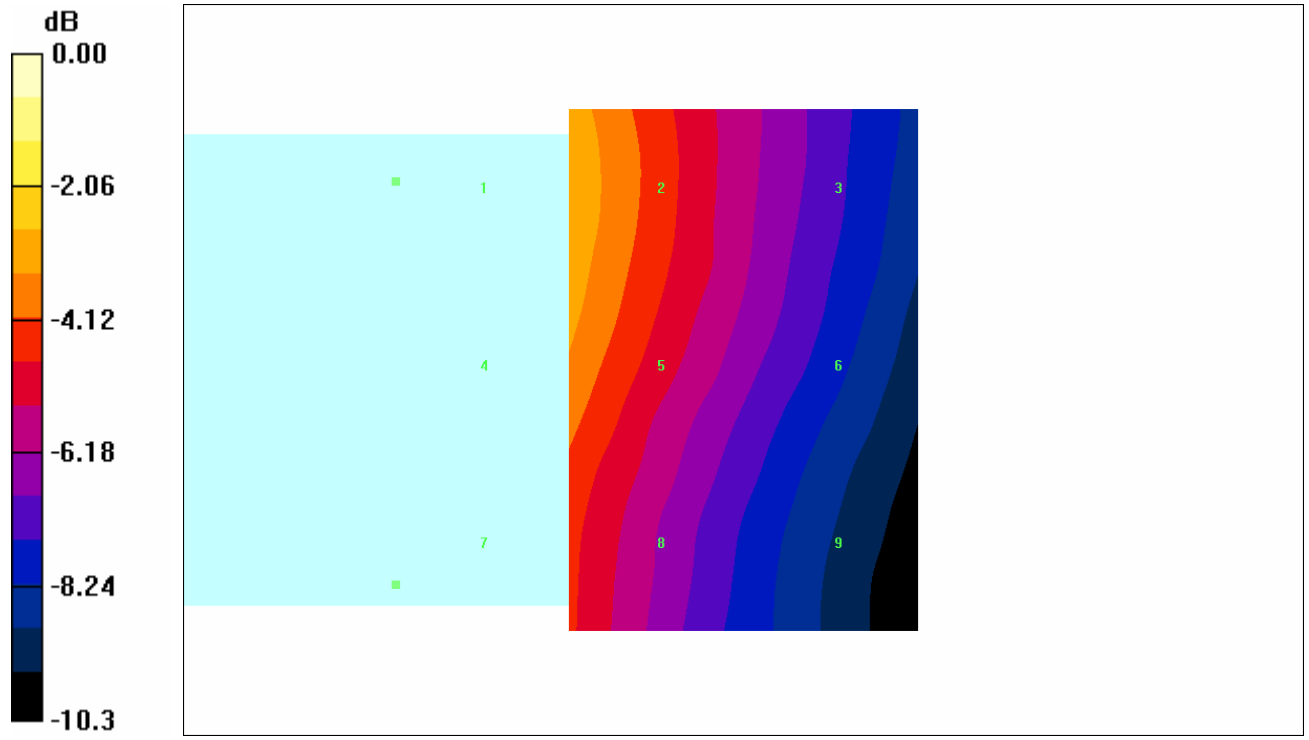
DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DASYS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan -L-ch (Backlight on)/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
 Maximum value of Total field (slot averaged) = 0.082 A/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged)			H in A/m (Slot averaged)		
Grid 1 0.114	Grid 2 0.082	Grid 3 0.058	Grid 1 0.114	Grid 2 0.082	Grid 3 0.058
Grid 4 0.112	Grid 5 0.080	Grid 6 0.056	Grid 4 0.112	Grid 5 0.080	Grid 6 0.056
Grid 7 0.100	Grid 8 0.070	Grid 9 0.050	Grid 7 0.100	Grid 8 0.070	Grid 9 0.050

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.114A/m

Test Laboratory: Compliance Certification Services

HAC_H_Device Cell band_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA Cellular band; Frequency: 824.7 MHz; Duty Cycle: 1:1
 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
 Phantom section: H Device Section
 Measurement Standard: DAS4 (High Precision Assessment)

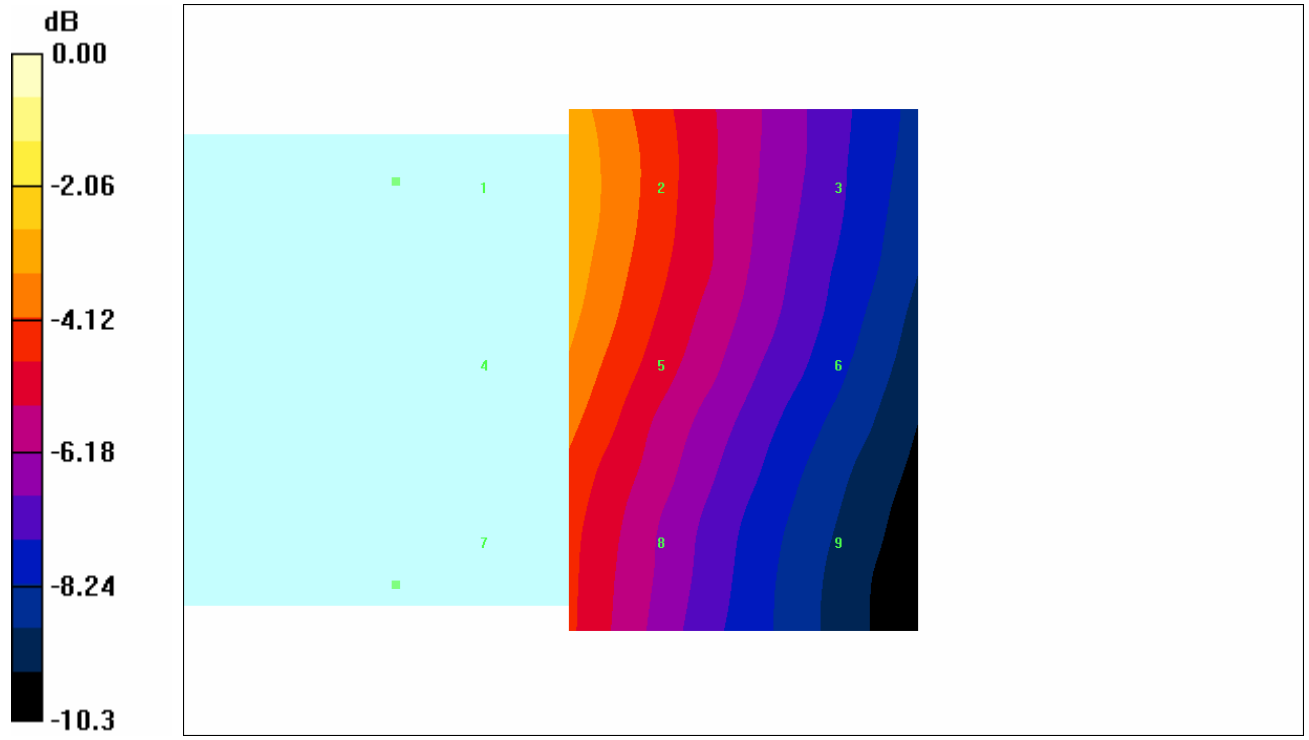
DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan -L-ch (Backlight on)/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
 Maximum value of Total field (slot averaged) = 0.082 A/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged)			H in A/m (Slot averaged)		
Grid 1 0.114	Grid 2 0.082	Grid 3 0.058	Grid 1 0.114	Grid 2 0.082	Grid 3 0.058
Grid 4 0.112	Grid 5 0.080	Grid 6 0.056	Grid 4 0.112	Grid 5 0.080	Grid 6 0.056
Grid 7 0.100	Grid 8 0.070	Grid 9 0.050	Grid 7 0.100	Grid 8 0.070	Grid 9 0.050

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.114A/m

Test Laboratory: Compliance Certification Services

HAC_H_Device Cell band_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA Cellular band; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan -H-ch (Backlight on)/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

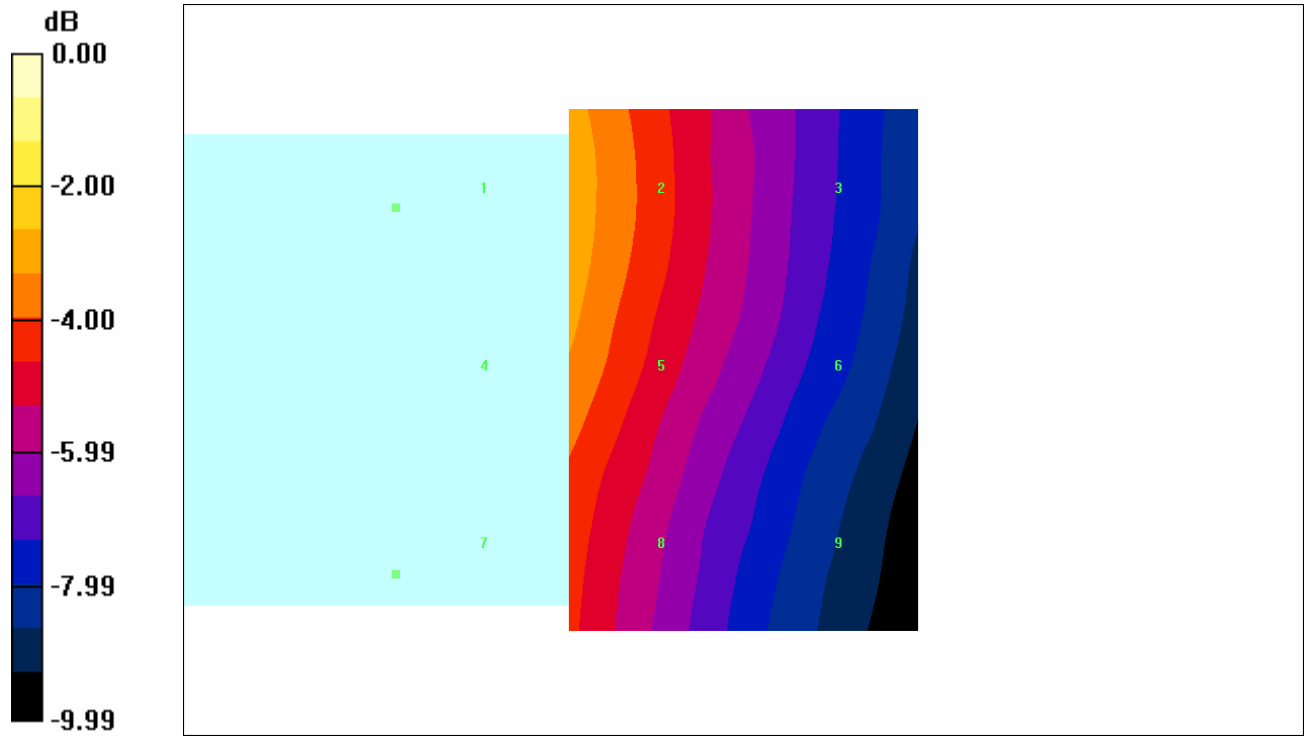
Maximum value of Total field (slot averaged) = 0.092 A/m

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1 0.128	Grid 2 0.092	Grid 3 0.065	Grid 1 0.128	Grid 2 0.092	Grid 3 0.065
Grid 4 0.126	Grid 5 0.091	Grid 6 0.064	Grid 4 0.126	Grid 5 0.091	Grid 6 0.064
Grid 7 0.113	Grid 8 0.081	Grid 9 0.058	Grid 7 0.113	Grid 8 0.081	Grid 9 0.058

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.128A/m

Test Laboratory: Compliance Certification Services

HAC_H_Device Cell band_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA Cellular band; Frequency: 824.7 MHz; Duty Cycle: 1:1
 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
 Phantom section: H Device Section
 Measurement Standard: DAS4 (High Precision Assessment)

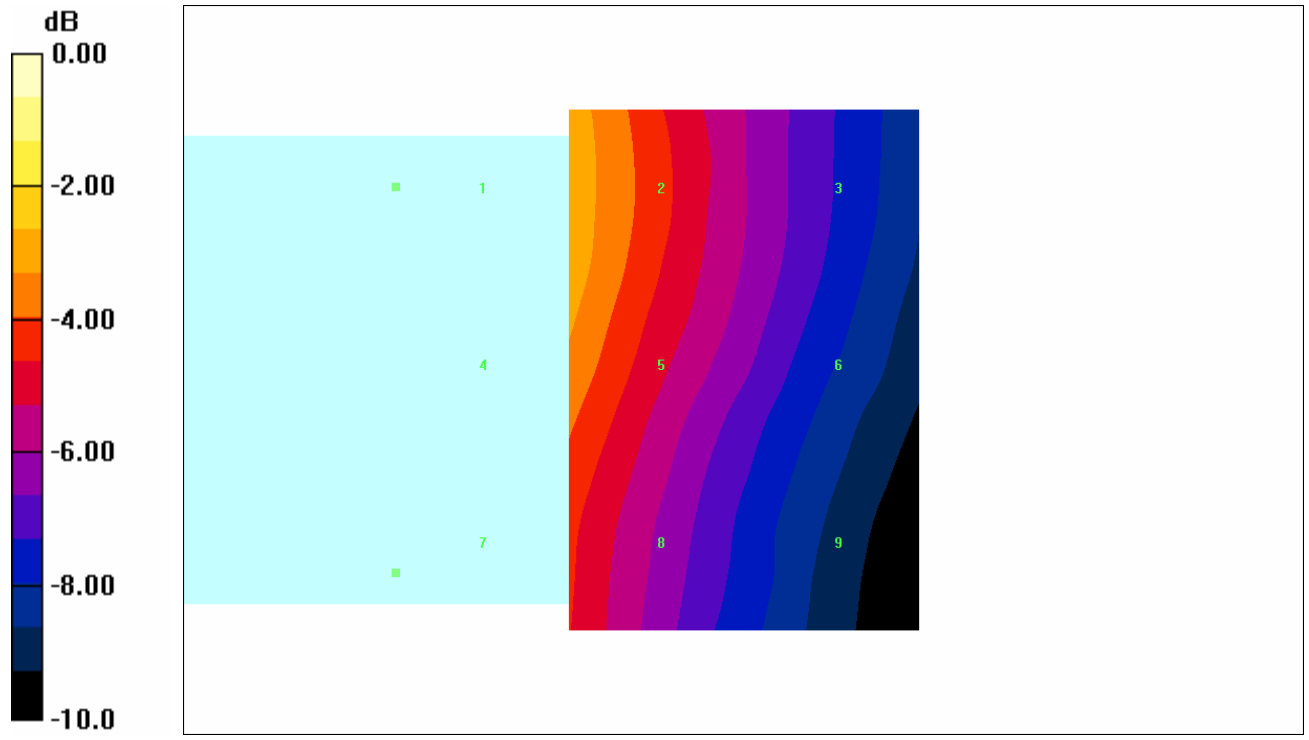
DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan -L-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
 Maximum value of Total field (slot averaged) = 0.081 A/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged)			H in A/m (Slot averaged)		
Grid 1 0.112	Grid 2 0.081	Grid 3 0.056	Grid 1 0.112	Grid 2 0.081	Grid 3 0.056
Grid 4 0.110	Grid 5 0.079	Grid 6 0.055	Grid 4 0.110	Grid 5 0.079	Grid 6 0.055
Grid 7 0.098	Grid 8 0.070	Grid 9 0.049	Grid 7 0.098	Grid 8 0.070	Grid 9 0.049

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.112A/m

Test Laboratory: Compliance Certification Services

HAC_H_Device Cell band_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA Cellular band; Frequency: 836.49 MHz; Duty Cycle: 1:1
 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
 Phantom section: H Device Section
 Measurement Standard: DAS4 (High Precision Assessment)

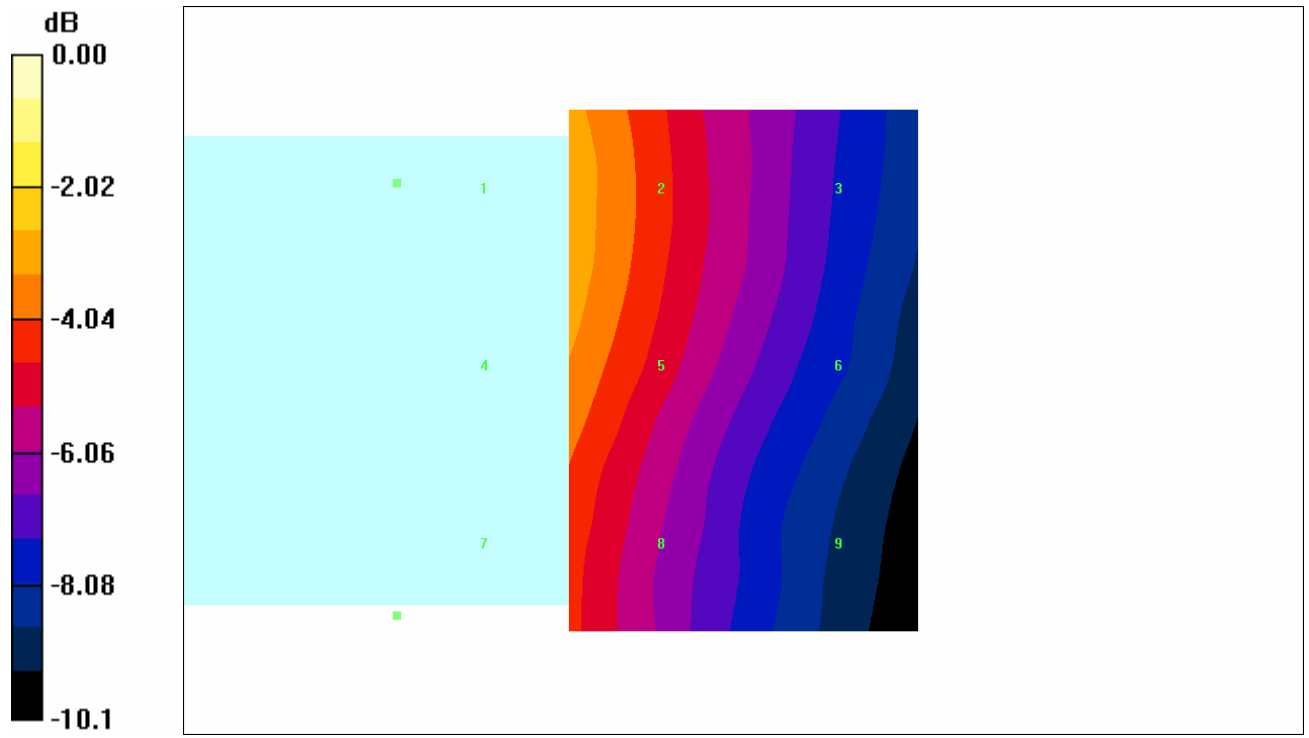
DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan -M-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
 Maximum value of Total field (slot averaged) = 0.095 A/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged)			H in A/m (Slot averaged)		
Grid 1 0.133	Grid 2 0.095	Grid 3 0.067	Grid 1 0.133	Grid 2 0.095	Grid 3 0.067
Grid 4 0.131	Grid 5 0.094	Grid 6 0.066	Grid 4 0.131	Grid 5 0.094	Grid 6 0.066
Grid 7 0.118	Grid 8 0.084	Grid 9 0.058	Grid 7 0.118	Grid 8 0.084	Grid 9 0.058

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.133A/m

Test Laboratory: Compliance Certification Services

HAC_H_Device Cell band_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA Cellular band; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan -H-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

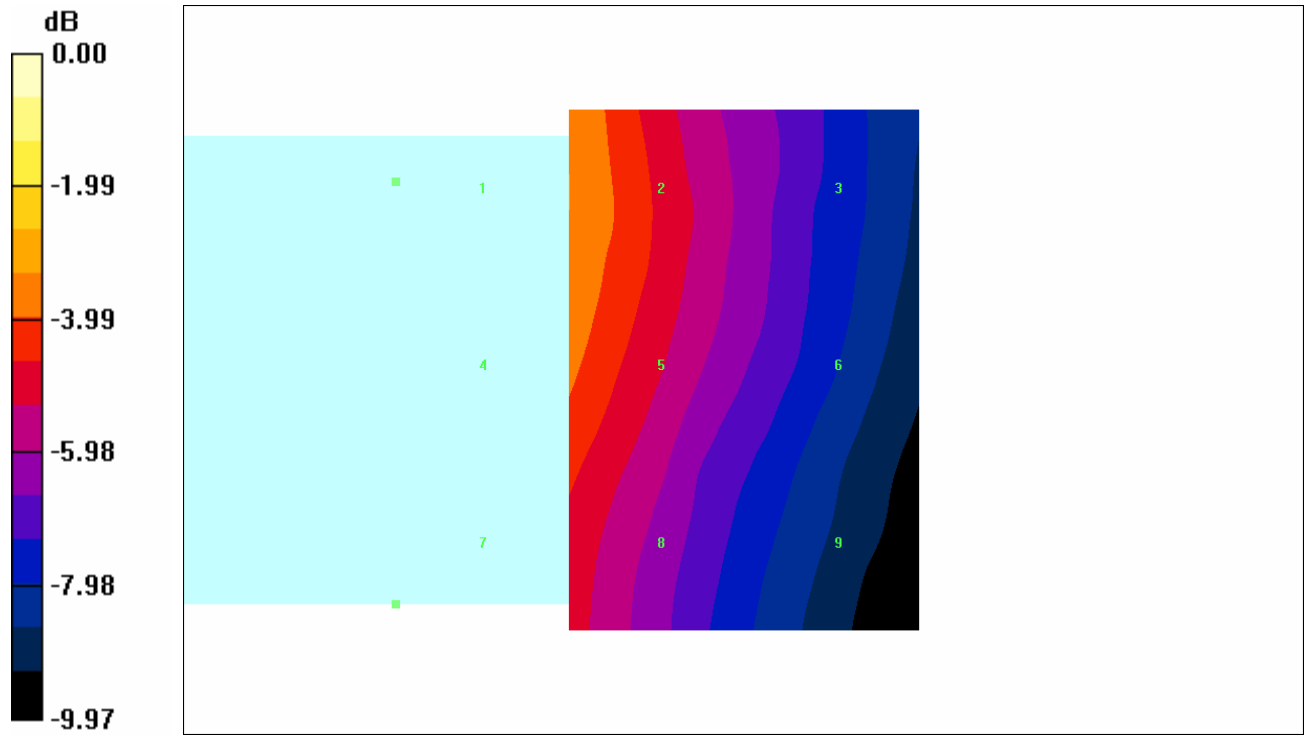
Maximum value of Total field (slot averaged) = 0.087 A/m

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1 0.127	Grid 2 0.087	Grid 3 0.063	Grid 1 0.127	Grid 2 0.087	Grid 3 0.063
Grid 4 0.124	Grid 5 0.086	Grid 6 0.062	Grid 4 0.124	Grid 5 0.086	Grid 6 0.062
Grid 7 0.106	Grid 8 0.077	Grid 9 0.056	Grid 7 0.106	Grid 8 0.077	Grid 9 0.056

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.127A/m

Test Laboratory: Compliance Certification Services

HAC_H-Device_Backlight on_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA PCS Band; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan - L-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

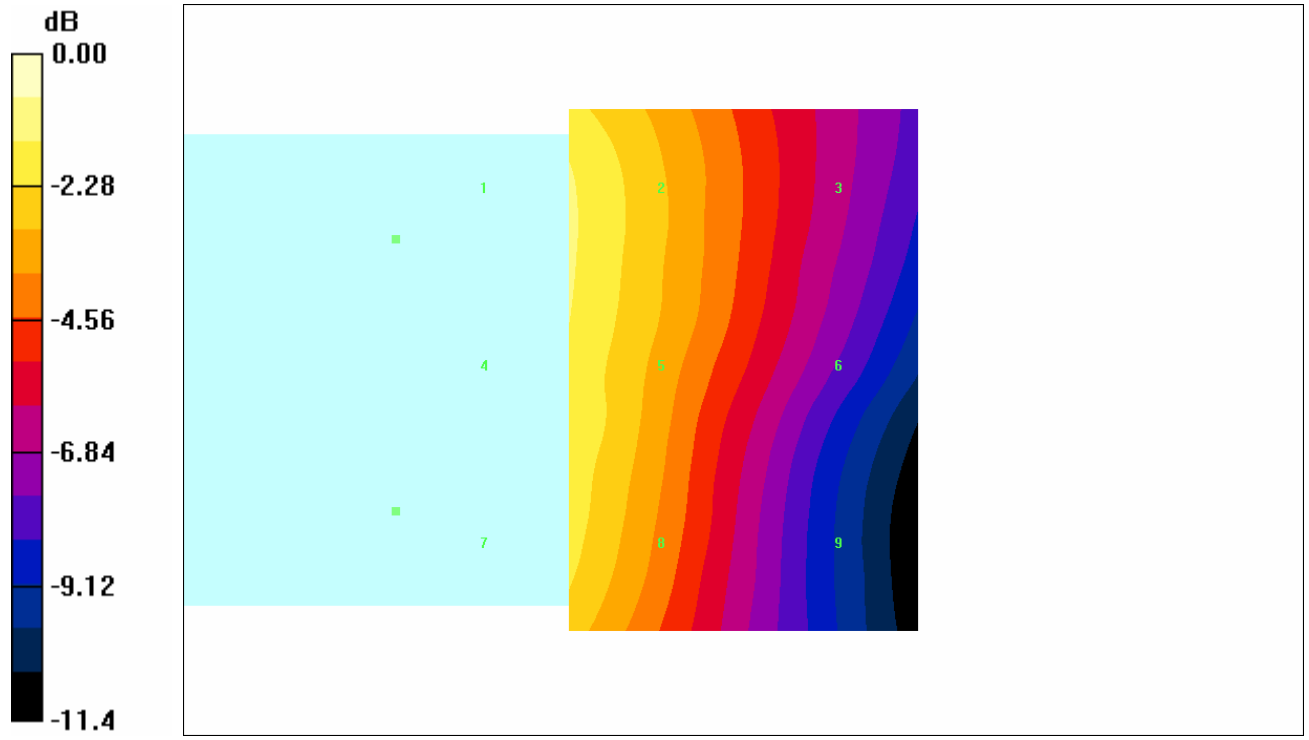
Maximum value of Total field (slot averaged) = 0.079 A/m

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1 0.093	Grid 2 0.079	Grid 3 0.055	Grid 1 0.093	Grid 2 0.079	Grid 3 0.055
Grid 4 0.093	Grid 5 0.079	Grid 6 0.054	Grid 4 0.093	Grid 5 0.079	Grid 6 0.054
Grid 7 0.093	Grid 8 0.076	Grid 9 0.046	Grid 7 0.093	Grid 8 0.076	Grid 9 0.046

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.093A/m

Test Laboratory: Compliance Certification Services

HAC_H-Device_Backlight on_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA PCS Band; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan - M-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

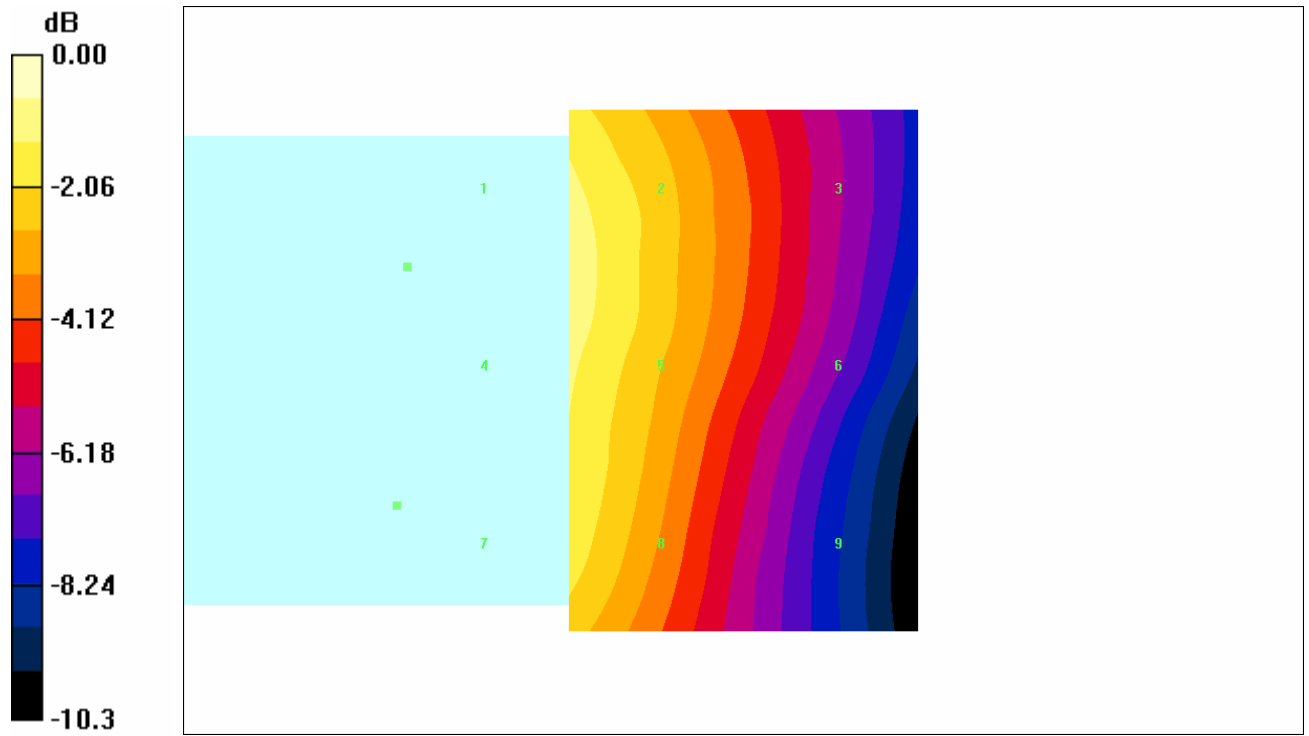
Maximum value of Total field (slot averaged) = 0.098 A/m

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1 0.109	Grid 2 0.098	Grid 3 0.069	Grid 1 0.109	Grid 2 0.098	Grid 3 0.069
Grid 4 0.110	Grid 5 0.098	Grid 6 0.069	Grid 4 0.110	Grid 5 0.098	Grid 6 0.069
Grid 7 0.110	Grid 8 0.093	Grid 9 0.060	Grid 7 0.110	Grid 8 0.093	Grid 9 0.060

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.110A/m

Test Laboratory: Compliance Certification Services

HAC_H-Device_Backlight on_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA PCS Band; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

Measurement Standard: DASYS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DASYS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan - H-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

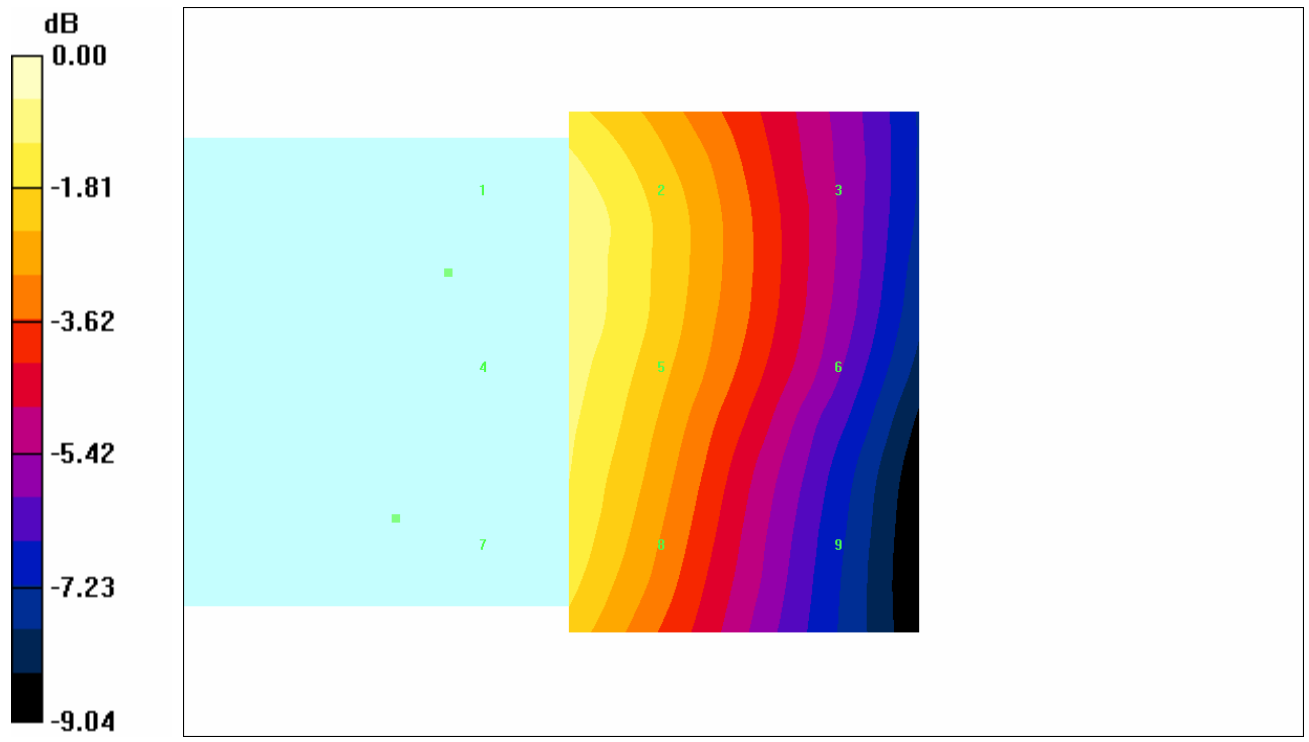
Maximum value of Total field (slot averaged) = 0.092 A/m

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1 0.097	Grid 2 0.092	Grid 3 0.067	Grid 1 0.097	Grid 2 0.092	Grid 3 0.067
Grid 4 0.099	Grid 5 0.092	Grid 6 0.067	Grid 4 0.099	Grid 5 0.092	Grid 6 0.067
Grid 7 0.100	Grid 8 0.088	Grid 9 0.059	Grid 7 0.100	Grid 8 0.088	Grid 9 0.059

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.100A/m

Test Laboratory: Compliance Certification Services

HAC_H-Device_Backlight off_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA PCS Band; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan - L-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

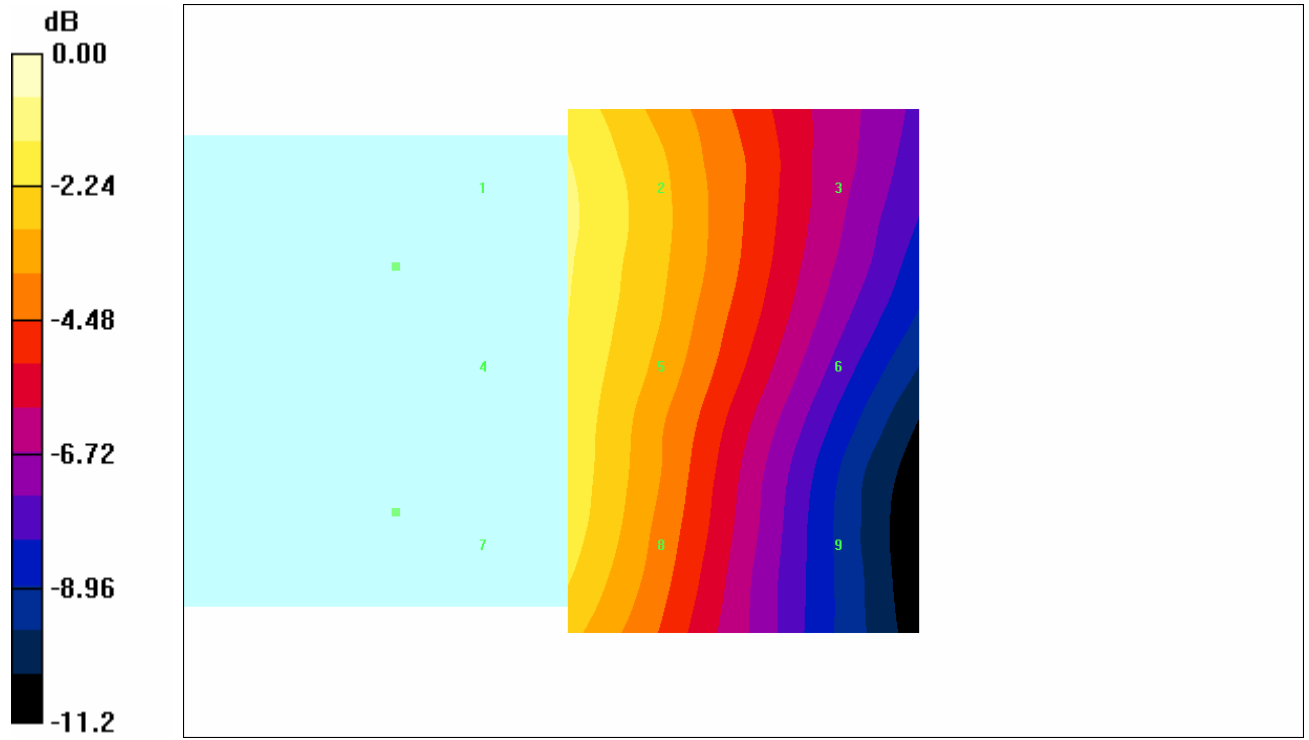
Maximum value of Total field (slot averaged) = 0.080 A/m

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1 0.093	Grid 2 0.080	Grid 3 0.056	Grid 1 0.093	Grid 2 0.080	Grid 3 0.056
Grid 4 0.093	Grid 5 0.079	Grid 6 0.054	Grid 4 0.093	Grid 5 0.079	Grid 6 0.054
Grid 7 0.093	Grid 8 0.076	Grid 9 0.046	Grid 7 0.093	Grid 8 0.076	Grid 9 0.046

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.093A/m

Test Laboratory: Compliance Certification Services

HAC_H-Device_Backlight off_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA PCS Band; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan - M-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

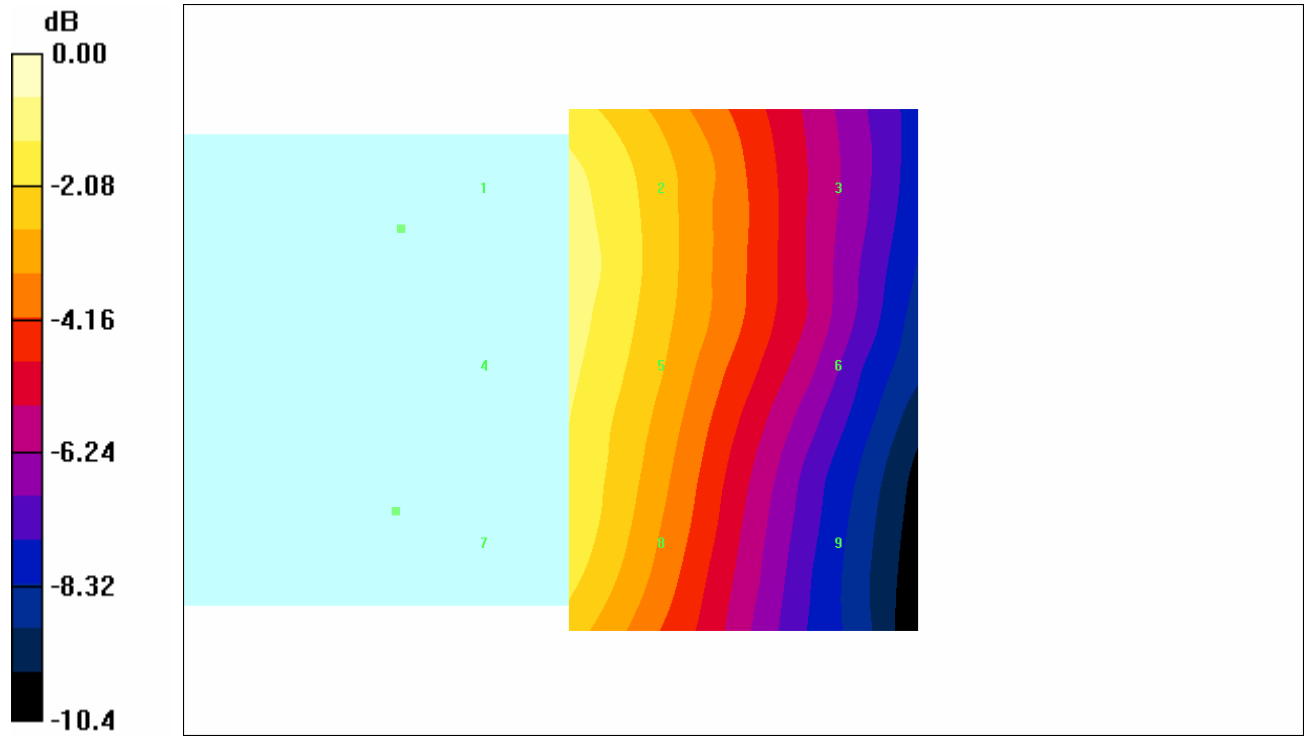
Maximum value of Total field (slot averaged) = 0.100 A/m

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1 0.111	Grid 2 0.100	Grid 3 0.070	Grid 1 0.111	Grid 2 0.100	Grid 3 0.070
Grid 4 0.111	Grid 5 0.100	Grid 6 0.070	Grid 4 0.111	Grid 5 0.100	Grid 6 0.070
Grid 7 0.112	Grid 8 0.095	Grid 9 0.061	Grid 7 0.112	Grid 8 0.095	Grid 9 0.061

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.112A/m

Test Laboratory: Compliance Certification Services

HAC_H-Device_Backlight off_072205

DUT: Kyocera; Type: KX9A; Serial: 20-N7092-01B

Communication System: CDMA PCS Band; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Device Section

Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6157; ; Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial: 1011
- Measurement SW: DAS4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

H Scan - H-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

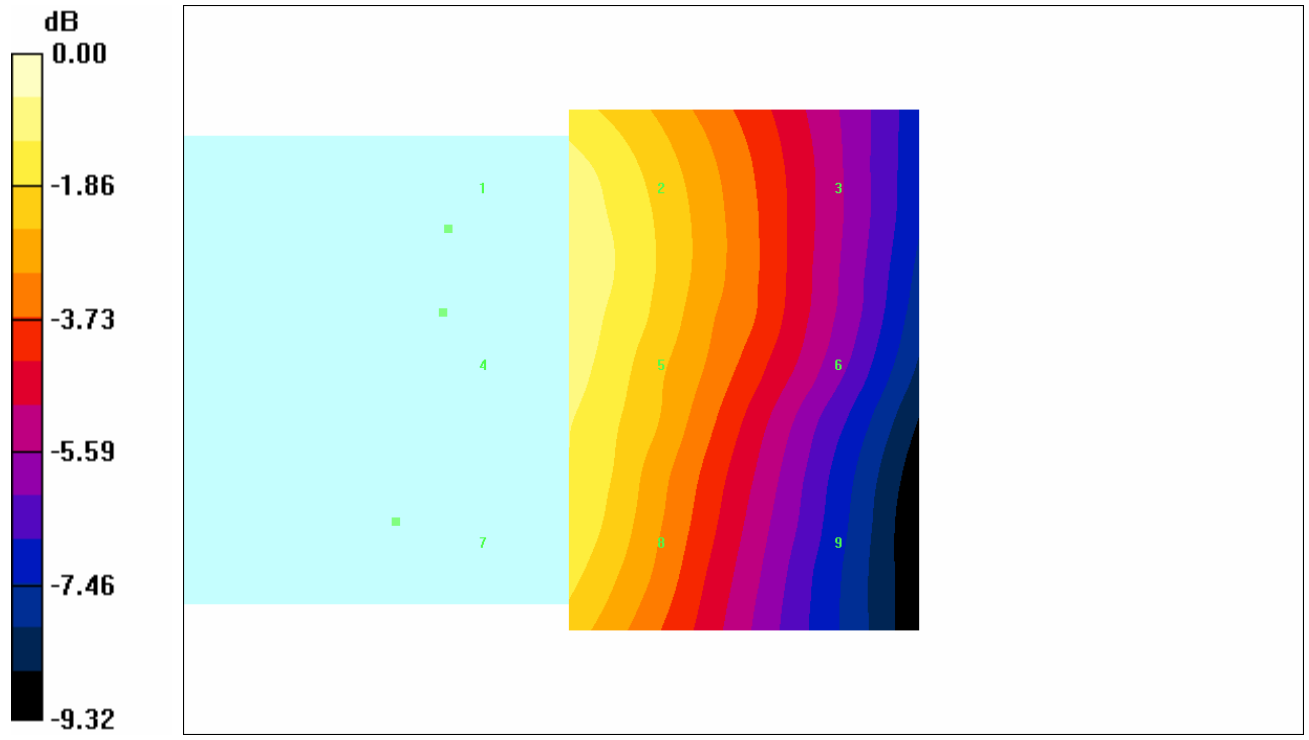
Maximum value of Total field (slot averaged) = 0.095 A/m

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1 0.100	Grid 2 0.095	Grid 3 0.069	Grid 1 0.100	Grid 2 0.095	Grid 3 0.069
Grid 4 0.101	Grid 5 0.094	Grid 6 0.068	Grid 4 0.101	Grid 5 0.094	Grid 6 0.068
Grid 7 0.102	Grid 8 0.089	Grid 9 0.060	Grid 7 0.102	Grid 8 0.089	Grid 9 0.060

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 0.102A/m